| PCN Number: | PCN Number: 20180319002 PCN Date: March 22, 2018 | | | | |
|--|--|-----------------------------------|-----------------------------|----------------------------------|--|
| Title: Datasheet for | itle: Datasheet for AMC1301, AMC1301S | | | | |
| Customer Contact: | PCN Manager | | Dep | t: Quality Services | |
| Change Type: | | | | | |
| Assembly Site | Design | | | Wafer Bump Site | |
| | | a Sheet | Sheet 🗌 Wafer Bump Material | | |
| Assembly Materials Part | | umber change 📃 Wafer Bump Process | | Wafer Bump Process | |
| Mechanical Specification Test | | | Wafer Fab Site | | |
| Packing/Shipping/Labeling Test | | Process | | Wafer Fab Materials | |
| | | | | Wafer Fab Process | |
| Notification Details | | | | | |
| Description of Change: | | | | | |
| Texas Instruments Incorporated is announcing an information only notification. | | | | | |
| The product datasheet(| | | w. | | |
| The following change hi | istory provides furthe | er detalls. | | | |
| TEXAS INSTRUMENTS | | | | AMC1301, AMC1301S | |
| | | | SBAS667 | 7E-APRIL 2016-REVISED MARCH 2018 | |
| Changes from Revision D (| January 2017) to Revision | n E | | Page | |
| Added AMC1301S device | e to document | | | | |
| | | | | 1 | |
| Added Device Comparison Table section | | | | | |
| Added AMC1301S row to T _A parameter in <i>Recommended Operating Conditions</i> table | | | | | |
| Added AMC1301S row to <i>Climatic category</i> parameter of <i>Insulation Specifications</i> table | | | | | |
| Added AMC1301S tempe | erature range to conditions | statement of Electrical Cl | haracterist | ics table7 | |
| Added AMC1301S row to TCV _{os} parameter in <i>Electrical Characteristics</i> table | | | | | |
| Changed I _{IB} parameter specification and conditions | | | | | |
| Added AMC1301S row to TCE _G parameter in <i>Electrical Characteristics</i> table | | | | | |
| Changed all temperature plots in Typical Characteristics section to cover –55°C for the AMC1301S and added respective footnote | | | | | |
| Changed Input Bias Current vs Common-Mode Input Voltage figure to align with new test condition | | | | | |
| Changed Input Bias Current vs High-Side Supply Voltage figure to align with new test condition | | | | | |
| Changed Input Bias Current vs Temperature figure to align with new test condition | | | | | |
| Changed legend of Output Voltage vs Input Voltage figure, Voutre is now red and Voutre is now black | | | | | |
| The datasheet number | will be changing. | | | | |
| Device Family | | Change From: | C | Change To: | |
| AMC1301, AMC1301S | | SBAS667D | | SBAS667E | |
| | | | 4 | | |
| These changes may be | reviewed at the data | isneet links provide | u. | | |
| http://www.ti.com/proc | <u>Juct/AMC1301</u> | | | | |
| Reason for Change: | | | | | |
| To accurately reflect device characteristics. | | | | | |
| Anticipated impact on Fit, Form, Function, Quality or Reliability (positive / negative): | | | | | |
| No anticipated impact. This is a specification change announcement only. The bias current | | | | | |
| definition has been adjusted based on customer inquiry to avoid misunderstanding. There are no | | | | | |
| changes to the actual device. | | | | | |
| Changes to product identification resulting from this PCN: | | | | | |
| None. | | | | | |
| | | | | | |
| Product Affected: | | | | | |
| AMC1301DWV | AMC1301DWVR | | | | |

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

| Location | E-Mail |
|--------------|--------------------------------|
| USA | PCNAmericasContact@list.ti.com |
| Europe | PCNEuropeContact@list.ti.com |
| Asia Pacific | PCNAsiaContact@list.ti.com |
| Japan | PCNJapanContact@list.ti.com |